## **Power MOSFET**

# 30 V, 48 A, Single N–Channel, SO–8 FL Features

- Low R<sub>DS(on)</sub> to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- Optimized Gate Charge to Minimize Switching Losses
- Dual Sided Cooling Capability
- Optimized for 5 V, 12 V Gate Drives
- These Devices are Pb–Free, Halogen Free/BFR Free and are RoHS Compliant

### Applications

- CPU Power Delivery
- DC–DC Converters
- **MAXIMUM RATINGS** (T<sub>1</sub> = 25°C unless otherwise stated)

|  |   |                            | 1                                    | ,              |      |
|--|---|----------------------------|--------------------------------------|----------------|------|
| Para   | meter   |                            | Symbol                               | Value          | Unit |
| Drain-to-Source Volt   | age   |                            | V <sub>DSS</sub>                     | 30             | V    |
| Gate-to-Source Volta   | age   |                            | V <sub>GS</sub>                      | ±20            | V    |
| Continuous Drain   |   | T <sub>A</sub> = 25°C      | ۱ <sub>D</sub>                       | 16.7           | Α    |
| Current R <sub>θJA</sub><br>(Note 1)   |   | T <sub>A</sub> = 100°C     |                                      | 10.5           |      |
| Power Dissipation $R_{\theta JA}$ (Note 1)   |   | T <sub>A</sub> = 25°C      | P <sub>D</sub>                       | 2.70           | W    |
| Continuous Drain   |   | T <sub>A</sub> = 25°C      | Ι <sub>D</sub>                       | 25.2           | А    |
| Current $R_{\theta JA} \le 10 \text{ s}$<br>(Note 1)   | Steady<br>State   | T <sub>A</sub> = 100°C     |                                      | 15.9           |      |
| Power Dissipation $R_{\theta JA} \leq 10 \text{ s} \text{ (Note 1)}$   |   | T <sub>A</sub> = 25°C      | PD                                   | 6.16           | W    |
| Continuous Drain   | Steady<br>State<br>$T_A = 25^{\circ}$<br>ackage<br>nd Storage<br>y Diode)<br>DT<br>o-Source A<br>$f_{DD} = 24 \text{ V},$<br>nH, R <sub>G</sub> = 25<br>r Soldering | T <sub>A</sub> = 25°C      | ۱ <sub>D</sub>                       | 9.7            | Α    |
| Current R <sub>θJA</sub><br>(Note 2)   |   | T <sub>A</sub> = 100°C     |                                      | 6.2            |      |
| Power Dissipation $R_{\theta JA}$ (Note 2)   |   | T <sub>A</sub> = 25°C      | PD                                   | 0.92           | W    |
| Continuous Drain   |   | T <sub>C</sub> = 25°C      | Ι <sub>D</sub>                       | 48             | Α    |
| Current R <sub>θJC</sub><br>(Note 1)   |   | T <sub>C</sub> =100°C      |                                      | 30             |      |
| Power Dissipation $R_{\theta JC}$ (Note 1)   | T <sub>A</sub> = 25°  | T <sub>C</sub> = 25°C      | PD                                   | 23.2           | W    |
| Pulsed Drain<br>Current  | T <sub>A</sub> = 25°  | °C, t <sub>p</sub> = 10 μs | I <sub>DM</sub>                      | 195            | A    |
| Current Limited by Pa  |   | T <sub>A</sub> = 25°C      | I <sub>Dmax</sub>                    | 100            | Α    |
| Operating Junction ar<br>Temperature   | nd Storage  | !                          | T <sub>J</sub> ,<br>T <sub>STG</sub> | –55 to<br>+150 | °C   |
| Source Current (Body   | / Diode)  |                            | ا <sub>S</sub>                       | 21             | Α    |
| Drain to Source DV/D   | T   |                            | dV/d <sub>t</sub>                    | 6.0            | V/ns |
| Single Pulse Drain-to-Source Avalanche<br>Energy (T <sub>J</sub> = 25°C, V <sub>DD</sub> = 24 V, V <sub>GS</sub> = 10 V,<br>I <sub>L</sub> = 26 A <sub>pk</sub> , L = 0.1 mH, R <sub>G</sub> = 25 $\Omega$ ) |   | E <sub>AS</sub>            | 34                                   | mJ             |      |
| Lead Temperature for<br>(1/8" from case for 10   |   | Purposes                   | ΤL                                   | 260            | °C   |
|  |   |                            |                                      |                |      |

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

1. Surface-mounted on FR4 board using 1 sq-in pad, 1 oz Cu.

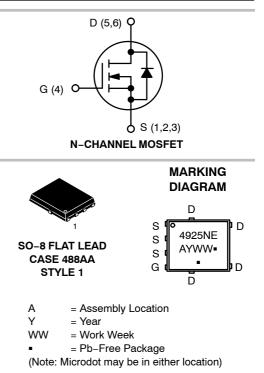
2. Surface-mounted on FR4 board using the minimum recommended pad size.



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| V <sub>(BR)DSS</sub> | R <sub>DS(ON)</sub> MAX       | I <sub>D</sub> MAX |
|----------------------|-------------------------------|--------------------|
| 30 V                 | $6.0~\mathrm{m}\Omega$ @ 10 V | 48 A               |
| 30 V                 | 10 mΩ @ 4.5 V                 | 40 A               |



#### **ORDERING INFORMATION**

| Device         | Package              | Shipping <sup>†</sup> |
|----------------|----------------------|-----------------------|
| NTMFS4925NET1G | SO-8 FL<br>(Pb-Free) | 1500 /<br>Tape & Reel |
| NTMFS4925NET3G | SO-8 FL<br>(Pb-Free) | 5000 /<br>Tape & Reel |

+For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

#### THERMAL RESISTANCE MAXIMUM RATINGS

| Parameter                                      | Symbol          | Value | Unit |
|--|-----------------|-------|------|
| Junction-to-Case (Drain)                       | $R_{\theta JC}$ | 5.4   |      |
| Junction-to-Ambient - Steady State (Note 3)    | $R_{\theta JA}$ | 46.3  |      |
| Junction-to-Ambient - Steady State (Note 4)    | $R_{\theta JA}$ | 136.2 | °C/W |
| Junction-to-Ambient – (t $\leq$ 10 s) (Note 3) | $R_{\theta JA}$ | 20.3  |      |
| Junction-to-Top                                | $R_{\theta JT}$ | 10.2  |      |

3. Surface-mounted on FR4 board using 1 sq-in pad, 1 oz Cu.

4. Surface-mounted on FR4 board using the minimum recommended pad size.

#### **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = $25^{\circ}C$ unless otherwise specified)

| Parameter  | Symbol                                   | Test Condition                                       |   | Min | Тур | Max  | Unit  |
|--|--|--|---|-----|-----|------|-------|
| OFF CHARACTERISTICS  |  |  |   |     |     |      |       |
| Drain-to-Source Breakdown Voltage                            | V <sub>(BR)DSS</sub>                     | $V_{GS}$ = 0 V, $I_D$ = 250 $\mu$ A                  |   | 30  |     |      | V     |
| Drain-to-Source Breakdown Voltage<br>Temperature Coefficient | V <sub>(BR)DSS</sub> /<br>T <sub>J</sub> |  |   |     | 21  |      | mV/°C |
| Zero Gate Voltage Drain Current                              | I <sub>DSS</sub>                         | V <sub>GS</sub> = 0 V,<br>V <sub>DS</sub> = 24 V     | $T_J = 25^{\circ}C$                     |     |     | 1.0  |       |
|  |  |  | $V_{DS} = 24 V$<br>$T_J = 125^{\circ}C$ |     |     | 10   | μΑ    |
| Gate-to-Source Leakage Current                               | I <sub>GSS</sub>                         | $V_{DS} = 0 V, V_{GS} = \pm 20 V$                    |   |     |     | ±100 | nA    |
| ON CHARACTERISTICS (Note 5)                                  |  |  |   |     |     |      |       |
| Gate Threshold Voltage                                       | V <sub>GS(TH)</sub>                      | V <sub>GS</sub> = V <sub>DS</sub> , I <sub>D</sub> = | = 250 μA                                | 1.2 | 1.7 | 2.2  | V     |
| Negative Threshold Temperature Coefficient                   | V <sub>GS(TH)</sub> /T <sub>J</sub>      |  |   |     | 3.9 |      | mV/°C |
| Drain-to-Source On Resistance                                | R <sub>DS(on)</sub>                      | V <sub>GS</sub> = 10 V                               | I <sub>D</sub> = 30 A                   |     | 4.0 | 6.0  |       |
|  |  |  | I <sub>D</sub> = 15 A                   |     | 4.0 |      |       |
|  |  | V <sub>GS</sub> = 4.5 V                              | I <sub>D</sub> = 30 A                   |     | 6.4 | 10   | mΩ    |
|  |  |  | I <sub>D</sub> = 15 A                   |     | 6.3 |      | 1     |
| Forward Transconductance                                     | <b>9</b> FS                              | $V_{DS}$ = 1.5 V, I <sub>D</sub>                     | ) = 15 A                                |     | 52  |      | S     |

#### **CHARGES, CAPACITANCES & GATE RESISTANCE**

| Input Capacitance            | C <sub>ISS</sub>    |  | 1264 |    |
|------------------------------|---------------------|--|------|----|
| Output Capacitance           | C <sub>OSS</sub>    | $V_{GS}$ = 0 V, f = 1 MHz, $V_{DS}$ = 15 V                             | 483  | pF |
| Reverse Transfer Capacitance | C <sub>RSS</sub>    |  | 143  |    |
| Total Gate Charge            | Q <sub>G(TOT)</sub> |  | 10.8 |    |
| Threshold Gate Charge        | Q <sub>G(TH)</sub>  |  | 2.0  | nC |
| Gate-to-Source Charge        | Q <sub>GS</sub>     | V <sub>GS</sub> = 4.5 V, V <sub>DS</sub> = 15 V; I <sub>D</sub> = 30 A | 3.8  | nc |
| Gate-to-Drain Charge         | Q <sub>GD</sub>     |  | 4.2  |    |
| Total Gate Charge            | Q <sub>G(TOT)</sub> | $V_{GS}$ = 10 V, $V_{DS}$ = 15 V; $I_{D}$ = 30 A                       | 21.5 | nC |

#### SWITCHING CHARACTERISTICS (Note 6)

| Turn–On Delay Time  | t <sub>d(ON)</sub>  |  | 9.5  |    |
|---------------------|---------------------|--|------|----|
| Rise Time           | t <sub>r</sub>      | V <sub>GS</sub> = 4.5 V, V <sub>DS</sub> = 15 V, | 32.7 | 20 |
| Turn-Off Delay Time | t <sub>d(OFF)</sub> | $I_{\rm D}$ = 15 A, $R_{\rm G}$ = 3.0 $\Omega$   | 16.4 | ns |
| Fall Time           | t <sub>f</sub>      |  | 6.2  |    |

 $\begin{array}{ll} \text{5. Pulse Test: pulse width} \leq 300 \ \mu\text{s} \text{, duty cycle} \leq 2\%. \\ \text{6. Switching characteristics are independent of operating junction temperatures.} \end{array}$ 

## **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = 25°C unless otherwise specified)

| Parameter                     | Symbol              | Test Condition  |             | Min  | Тур   | Max | Unit |
|-------------------------------|---------------------|---|-------------|------|-------|-----|------|
| SWITCHING CHARACTERISTICS (No | ote 6)              |   |             |      |       |     |      |
| Turn-On Delay Time            | t <sub>d(ON)</sub>  | V <sub>GS</sub> = 10 V, V <sub>DS</sub> = 15 V,                                 |             |      | 7.4   |     |      |
| Rise Time                     | tr                  |   |             |      | 27.5  |     | 1    |
| Turn-Off Delay Time           | t <sub>d(OFF)</sub> | $I_{\rm D} = 15  \rm A,  R_{\rm G}$   | = 3.0 Ω     |      | 20.3  |     | ns   |
| Fall Time                     | t <sub>f</sub>      |   |             |      | 4.1   |     |      |
| DRAIN-SOURCE DIODE CHARACTE   | ERISTICS            |   |             |      |       |     |      |
| Forward Diode Voltage         | V <sub>SD</sub>     | $V_{GS} = 0 V, \\ I_{S} = 30 A \\ T_{J} = 125^{\circ}C \\ T_{J} = 125^{\circ}C$ |             | 0.86 | 1.1   | v   |      |
|                               |                     |   |             | 0.75 |       |     |      |
| Reverse Recovery Time         | t <sub>RR</sub>     |   |             |      | 25.8  |     |      |
| Charge Time                   | t <sub>a</sub>      | V <sub>GS</sub> = 0 V, dIS/dt   | = 100 A/μs, |      | 12.4  |     | ns   |
| Discharge Time                | t <sub>b</sub>      | I <sub>S</sub> = 30   | A           |      | 13.4  |     |      |
| Reverse Recovery Charge       | Q <sub>RR</sub>     | 1   |             |      | 13.6  |     | nC   |
| PACKAGE PARASITIC VALUES      |                     |   |             |      |       |     |      |
| Source Inductance             | LS                  | T <sub>A</sub> = 25°C   |             |      | 1.00  |     | nH   |
| Drain Inductance              | L <sub>D</sub>      |   |             |      | 0.005 |     | nH   |
| Gate Inductance               | L <sub>G</sub>      |   |             |      | 1.84  |     | nH   |
|                               |                     |   |             |      |       |     |      |

0.8

2.2

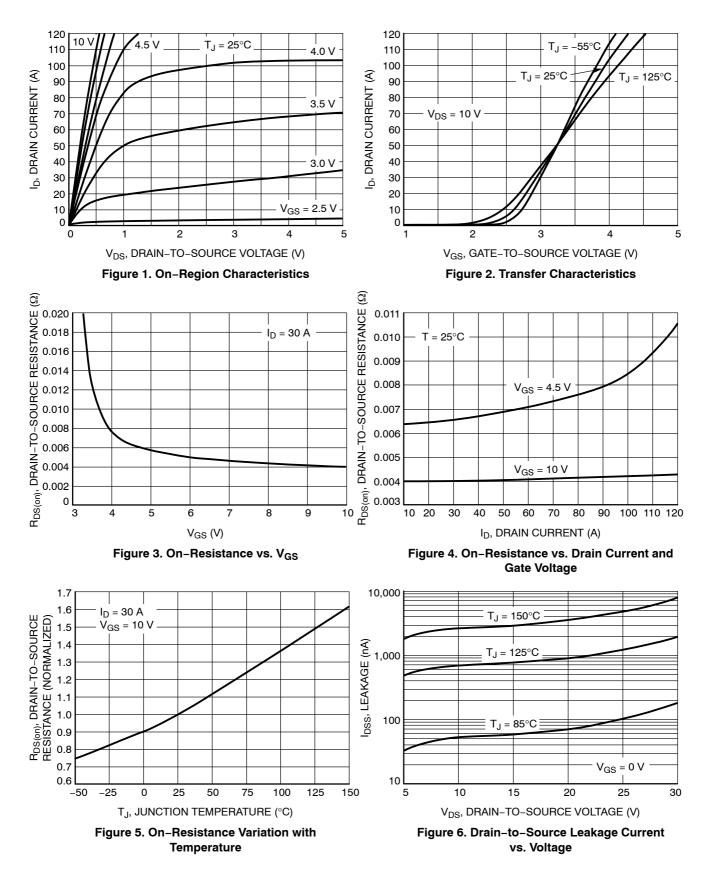
Ω

Gate Resistance

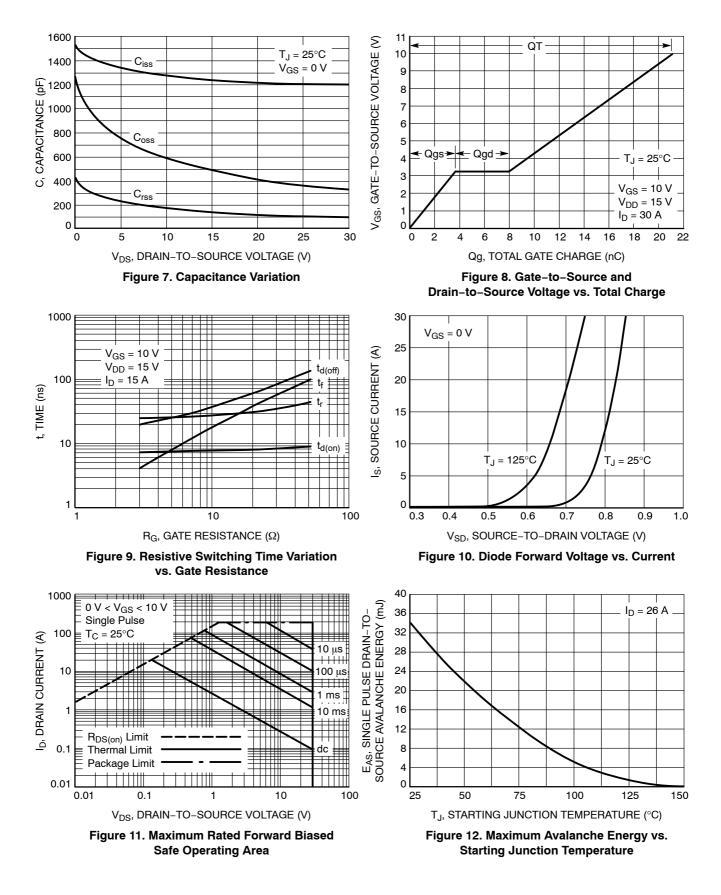
 $\begin{array}{ll} \text{5. Pulse Test: pulse width} \leq 300 \ \mu\text{s} \text{, duty cycle} \leq 2\%. \\ \text{6. Switching characteristics are independent of operating junction temperatures.} \end{array}$ 

 $\mathsf{R}_\mathsf{G}$ 

## **TYPICAL CHARACTERISTICS**



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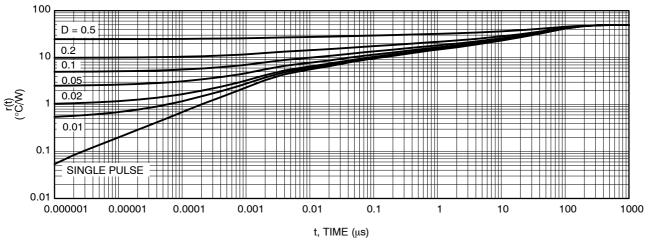
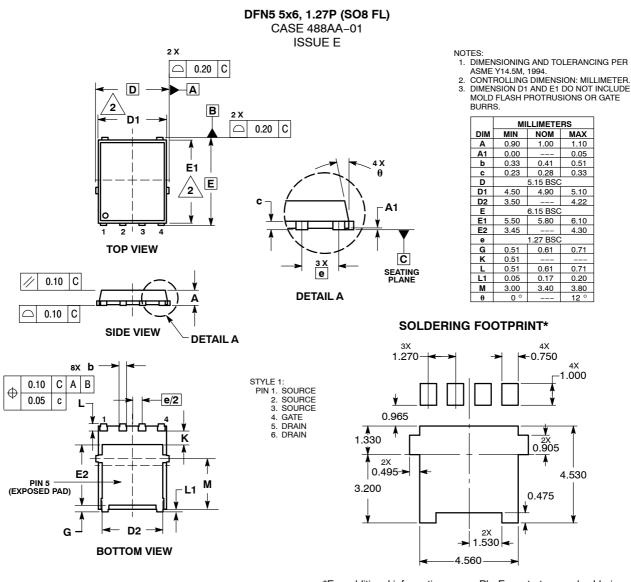


Figure 13. Thermal Response

#### PACKAGE DIMENSIONS



\*For additional information on our Pb–Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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